

APPENDIX 3: Photographs of test setup

Conducted Emission

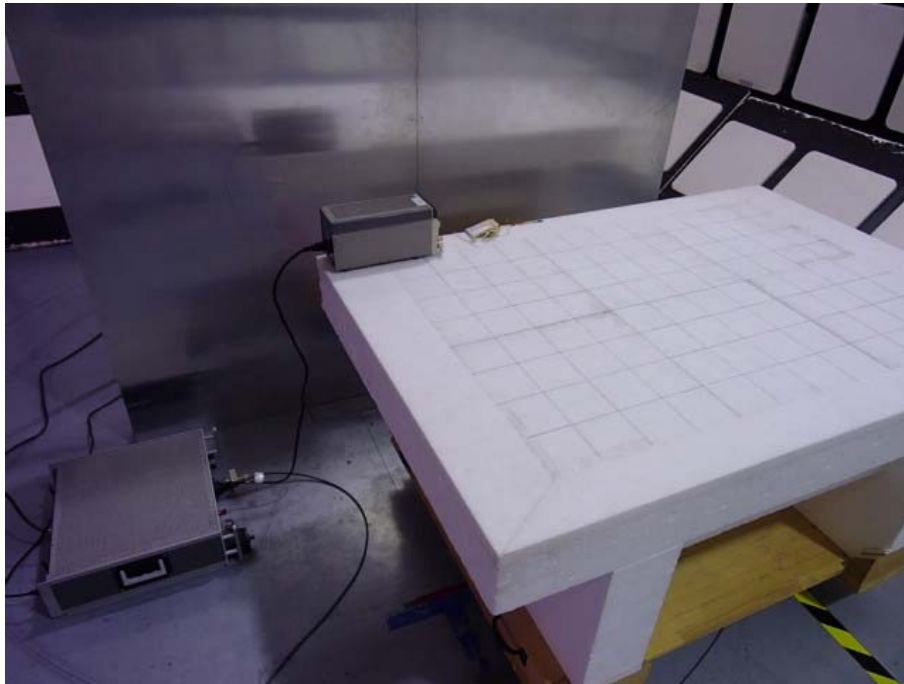


Photo 1

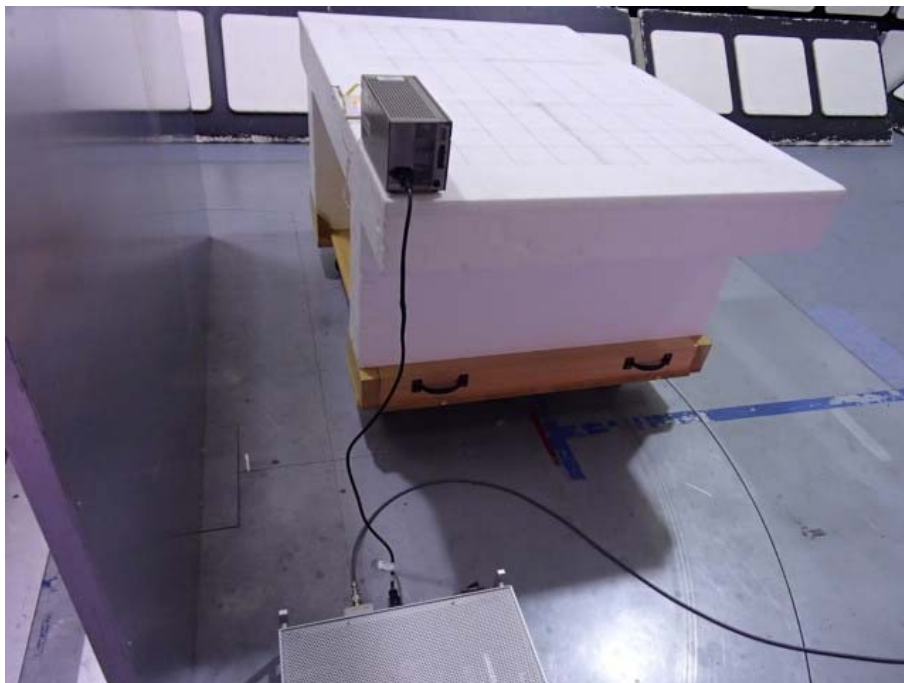


Photo 2

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Radiated Spurious Emission

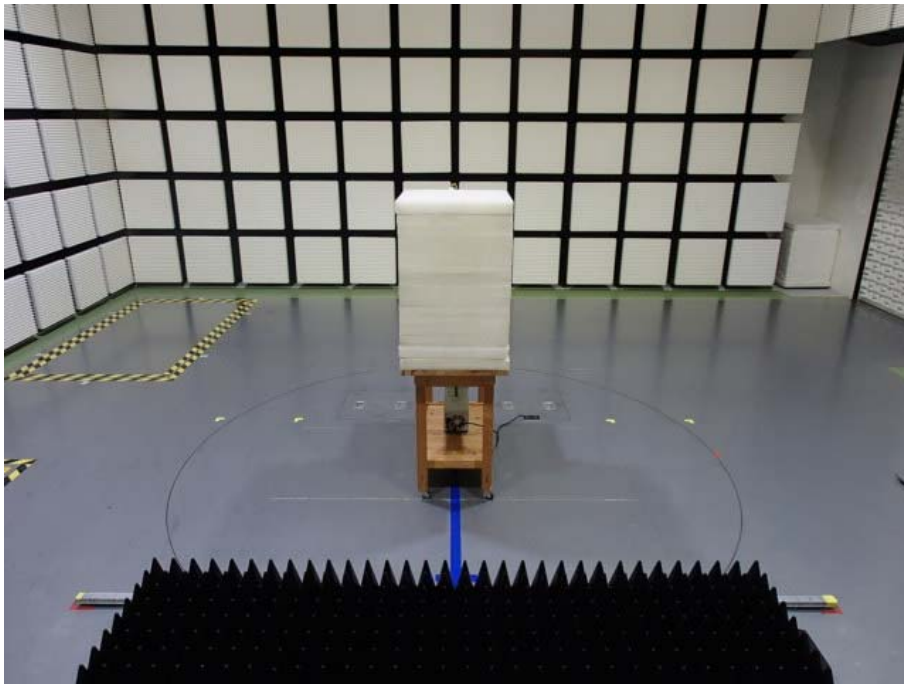


Photo 1

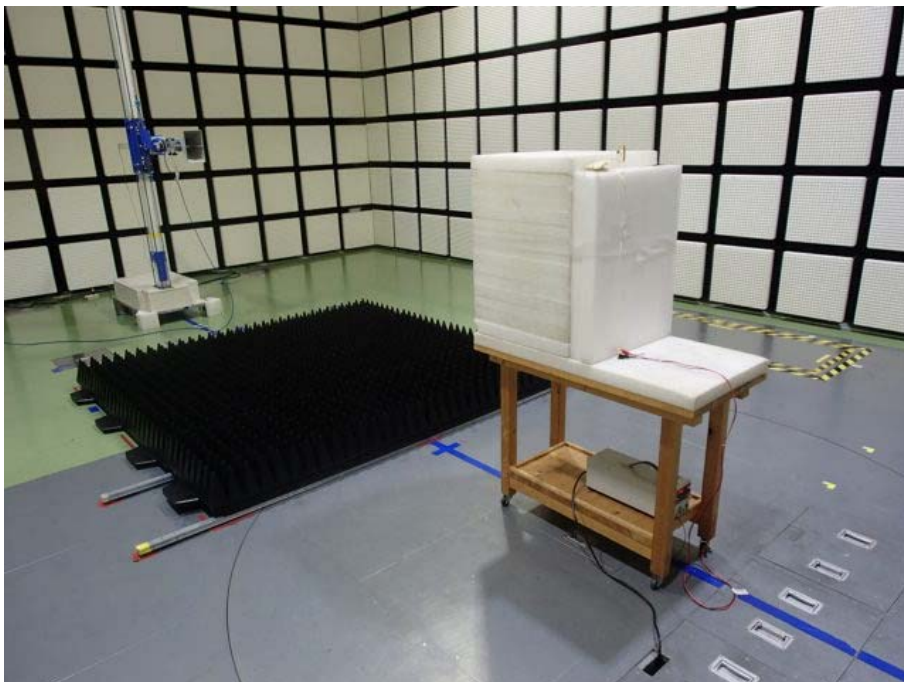


Photo 2

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Worst Case Position

Below 1 GHz

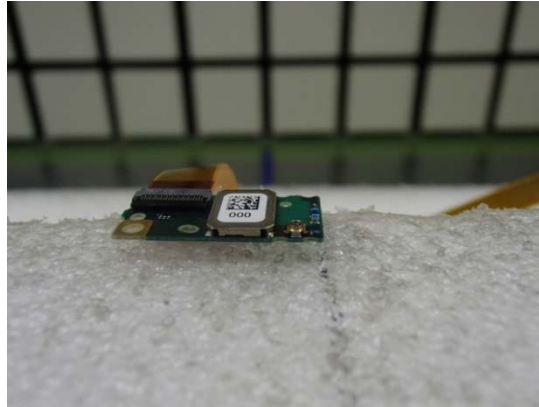
(Horizontal: X-axis/ Vertical: X-axis)

Above 1 GHz

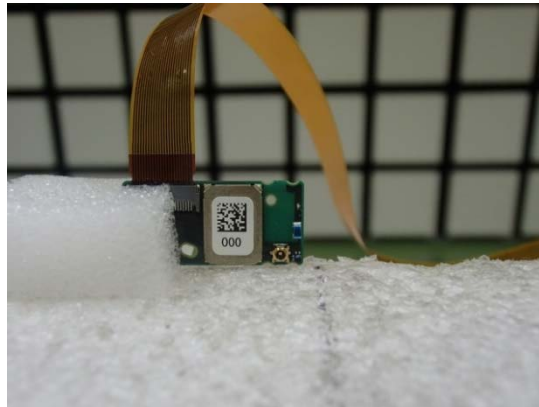
(Horizontal: X-axis/ Vertical: Y-axis: Radiated Spurious Emission (Band Edge) /

Horizontal: Y-axis/ Vertical: Y-axis: Radiated Spurious Emission (other))

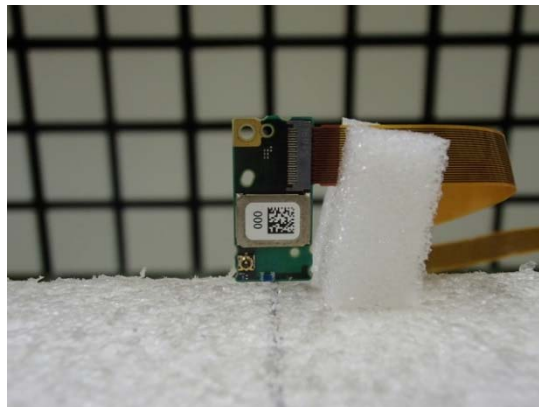
X-axis



Y-axis



Z-axis



End of Report

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